

**Session Program**

**16-18 Oct 2006**

**9th RD50 Workshop**

***Defect and Material Characterization & New  
Materials***

CERN, 40-SS-C01

# Monday 16 October

09:45

## Defect and Material Characterization & New Materials

Session | Location: CERN, 40-SS-C01

09:45-10:05

**Results of the simultaneous investigation of the microwave probed photoconductivity and current transients in proton irradiated FZ Si pad detectors**

**Speaker**

Eugenijus Gaubas

10:05-10:25

**Recent results on CdZnTe and SiGe devices**

**Speaker**

Arie Ruzin

10:25-10:55

**Coffee Break**

10:55-11:25

**Discussion Session (Defect and Material Characterization & New Materials)**

11:25